IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of

Hideaki MATSUHASHI

Attn: APPLICATION BRANCH

Serial No. NEW Filed June 23, 2003

Attorney Docket No. 2003-0859A

SEMICONDUCTOR DEVICE

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to the provisions of 37 CFR 1.56, 1.97 and 1.98, Applicant requests consideration of [X] the references listed on attached form PTO-1449 and/or [] the additional information identified below in paragraph 3. A legible copy of each reference listed on the form PTO-1449 and each U.S. patent application listed below is enclosed, except a copy is not provided for each reference previously cited by or submitted to the Patent Office in prior parent application Serial No.

la. [X] This Information Disclosure Statement is submitted:

> within three months of the filing date (or of entry into the National Stage) of the aboveentitled application, or

before the mailing date of the first Office Action on the merits,

and thus no certification and/or fee is required.

1b. [] This Information Disclosure Statement is submitted after the events of above paragraph 1a and prior to the mailing date of a final Office Action or a Notice of Allowance or an action which otherwise closes prosecution in the application, and thus:

- (1) [] the certification of paragraph 2 below is provided, or
- (2) [] the fee of \$180.00 specified in 37 CFR 1.17(p) is enclosed.
- 1c. [] This Information Disclosure Statement is submitted:

after the mailing date of a final Office Action or Notice of Allowance or action which otherwise closes prosecution in the application, and prior to payment of the issue fee, and thus:

the certification of paragraph 2 below is provided, and

the fee of \$180.00 specified in 37 CFR 1.17(p) is enclosed.

- 2. It is hereby certified
 - a. [] that each item of information contained in this Information Disclosure Statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the Statement, or
 - b. [] that no item of information contained in the Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application and, to the knowledge of the person signing the certification after making reasonable inquiry, was known to any individual designated in §1.56(c) more than three months prior to the filing of the Statement.
- 3. [] Consideration of the following list of additional information (including any copending or abandoned U.S. application, prior uses and/or sales, etc.) is requested.
- 4. For each non-English language reference listed on the attached form PTO-1449, reference is made to:
 - a. [] a full or partial English language translation submitted herewith,

- b. [] a foreign patent office search report (in the English language) submitted herewith,
- c. [] the concise explanation contained in the specification of the present application at page,
- d. [X] the concise explanation set forth in the attached English language abstract,
- e. [] the concise explanation set forth below or on a separate sheet attached to the reference:
- 5. [] A foreign patent office search report citing one or more of the references is enclosed.

Respectfully submitted,

Hideaki MAŢŞUHASHI

Nils E. Pedersen

Registration No. 33,145 Attorney for Applicant

NEP/krl

Washington, D.C. 20006-1021 Telephone (202) 721-8200 Facsimile (202) 721-8250 June 23, 2003

> THE COMMISSIONER IS AUTHORIZED TO CHARGE ANY DEPOIENCY IN THE TALES FOR THIS PAPER TO DEPOSIT ACCOUNT NO. 22-0975

Sheet 1 of 1									
FORM PTO 1449 (n		TMENT OF COMMERCE	2003-08				NO.		
PAT LIST OF	ENT AN REFEREN	D TRADEMARK OFFICE	APPLICANT Hideaki MATSUHASHI						
		ral sheets if necessary) and to PTO: June 23, 20	FILING DATE June 23, 2003			GROUP	GROUP		
U.S. PATENT DOCUMENTS									
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE			FILING D APPROP			
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FOREIGN PATENT DOCUMENTS									
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	AJ	9-246556	9/1997		JP			abstract	
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OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)									
	AO	Cheng-Liang Huang et al., "LOCOS-Induced Stress Effects on Thin-Film SOI Devices", IEEE ELECTRON DEVICE LETTERS, vol. 44, no. 4, April 1997, pgs. 646-650.							
	АР								
	AQ								
EXAMINER					DATE CONSIDERED				

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.